Search Notes			

	Application/Control No.	Applicant(s)/Patent under Reexamination	-
	10/643,644	CHEN ET AL.	
Ì	Examiner	Art Unit	
١	Usmaan Saeed	2166	

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Class	Subclass	Date	Examiner
707	200	2/15/2006	US
707	2	2/15/2006	US
707	3	2/15/2006	us
707	104.1	2/15/2006	US
707	201	2/15/2006	US

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor & related case search	2/14/2006	US
East (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)	2/14/2006	US
Plus	2/14/2006	US
NPL (Google, ACM, IEEE)	2/14/2006	us